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Q1PACK Module

NXH50M65L4Q1SG, NXH50M65L4Q1PTG

This high-density, integrated power module combines high-performance IGBTs with rugged anti-parallel diodes.

Features

- Extremely Efficient Trench with Fieldstop Technology
- Low Switching Loss Reduces System Power Dissipation
- Module Design Offers High Power Density
- Low Inductive Layout
- Q1PACK Packages with Solder and Pressfit Pins

Typical Applications

- Solar Inverters
- Uninterruptable Power Supplies

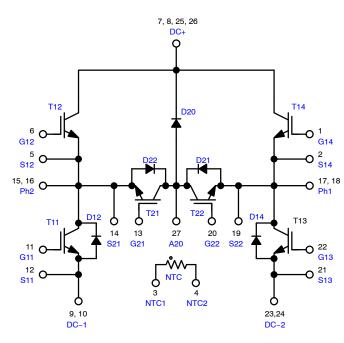


Figure 1. Schematic

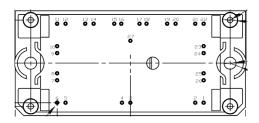


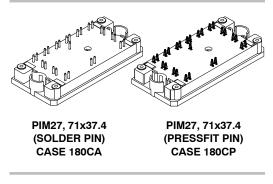
Figure 2. Pin Assignments



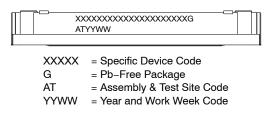
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50 A, 650 V Module



MARKING DIAGRAM



ORDERING INFORMATION

See detailed ordering and shipping information on page 9 of this data sheet.

ABSOLUTE MAXIMUM RATINGS

| Rating | Symbol | Value | Unit |
|------------------------------------------------------------------------------------------------------------|--------------------|---------------------------------|------|
| GBT (T11, T12, T13, T14, T21, T22) | | - | |
| Collector-emitter voltage | V _{CES} | 650 | V |
| Collector current @ $T_h = 80^{\circ}C$ (per IGBT) | Ι _C | 48 | А |
| Pulsed collector current, T _{pulse} limited by T _{jmax} | I _{CM} | 144 | Α |
| Power Dissipation Per IGBT $T_j = T_{jmax}$, $T_h = 80^{\circ}C$ | P _{tot} | 72 | W |
| Gate-emitter voltage | V _{GE} | ±20 | V |
| Maximum Junction Temperature | TJ | 175 | °C |
| DIODE (D12, D14, D20, D21, D22) | | | |
| Peak Repetitive Reverse Voltage | V _{RRM} | 650 | V |
| Forward Current, DC @ $T_h = 80^{\circ}C$ (per Diode) | ١ _F | 50 | А |
| Nonrepetitive Peak Surge Current (Surge applied at rated load conditions halfwave, single phase, 60 Hz) | I _{FSM} | 225 | A |
| Power Dissipation Per Diode $T_j = T_{jmax}, T_h = 80^{\circ}C$ | P _{tot} | 86 | W |
| Maximum Junction Temperature | TJ | 175 | °C |
| HERMAL PROPERTIES | | - | |
| Operating Temperature under switching condition | T _{VJ OP} | –40 to (T _{jmax} – 25) | °C |
| Storage Temperature range | T _{stg} | -40 to 125 | °C |
| NSULATION PROPERTIES | | | |
| Isolation test voltage, t = 2 min, 60 Hz | V _{is} | 4000 | Vac |
| Creepage distance | | 12.7 | mm |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

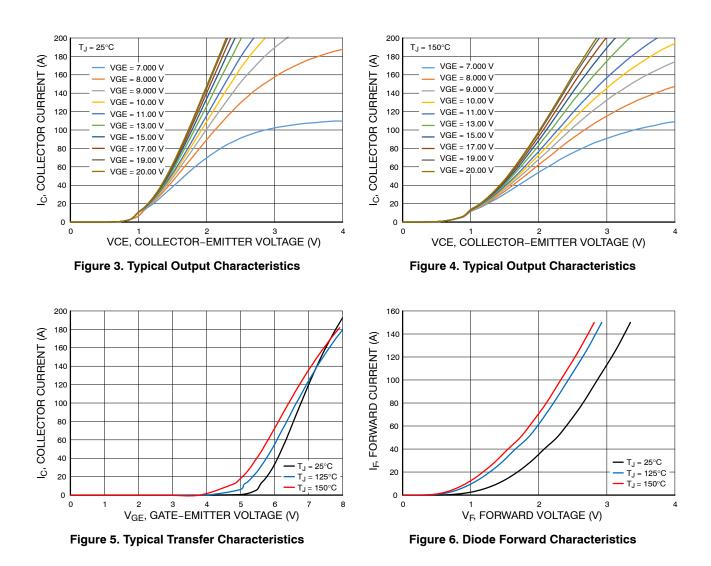
| Parameter | Test Condition | Symbol | Min | Тур | Max | Unit | | |
|--------------------------------------|----------------------------------------------------------------------------------------------------------------------------------------|----------------------|-----|--------------|-----------|------|--|--|
| GBT (T11, T12, T13, T14, T21, T22) | | | | | | | | |
| Collector-emitter cutoff current | V _{GE} = 0 V, V _{CE} = 650 V | I _{CES} | - | - | 300 | μΑ | | |
| Collector-emitter saturation voltage | V_{GE} = 15 V, I _C = 50 A, T _j = 25°C V _{GE} = 15 V, I _C = 50 A, T _j = 150°C | V _{CE(sat)} | | 1.56 1.76 | 2.22 _ | V | | |
| Gate-emitter threshold voltage | $V_{GE} = V_{CE}, I_C = 50 \text{mA}$ | V _{GE(TH)} | 3.1 | 4.45 | 5.2 | V | | |
| Gate leakage current | $V_{GE} = 20 \text{ V}, \text{ V}_{CE} = 0 \text{ V}$ | I _{GES} | - | - | 400 | nA | | |
| Turn-on delay time | T _i = 25°C V _{CE} =350 V, I _C = 50 A | t _{d(on)} | - | 14 | - | ns | | |
| Rise time | $V_{CE} = 350$ V, I _C = 50 A V _{GE} = 15 V, -9 V, R _G = 6 Ω | t _r | - | 20 | — | | | |
| Turn-off delay time | | t _{d(off)} | - | 68 | - | | | |
| Fall time | | t _f | - | 20 | - | | | |
| Turn on switching loss | | E _{on} | - | 0.46 | — | mJ | | |
| Turn off switching loss | | E _{off} | - | 0.44 | - | | | |
| Turn-on delay time | $T_j = 125^{\circ}C$ | t _{d(on)} | - | 16 | — | ns | | |
| Rise time | V'_{CE} = 350 V, I _C = 50 A V _{GE} = 15 V, -9 V, R _G = 6 Ω | t _r | - | 23 | - | | | |
| Turn-off delay time | | t _{d(off)} | - | 78 | - | | | |
| Fall time | | t _f | - | 52 | — | | | |
| Turn on switching loss | 7 | Eon | - | 0.78 | - | mJ | | |
| Turn off switching loss | 7 | E _{off} | - | 0.60 | - | | | |

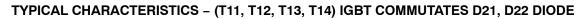
ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified) (continued)

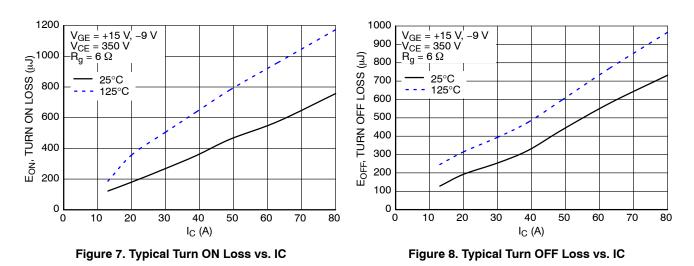
| Parameter | Test Condition | Symbol | Min | Тур | Max | Unit |
|---------------------------------------|---------------------------------------------------------------------------------------------------|----------------------|-----|-------------|----------|-------|
| GBT (T11, T12, T13, T14, T21, T22) | | | - | - | | - |
| Input capacitance | $V_{CE} = 20 \text{ V}, \text{ V}_{GE} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$ | Cies | - | 3137 | - | pF |
| Output capacitance | | C _{oes} | - | 146 | - | |
| Reverse transfer capacitance | | C _{res} | - | 17 | - | |
| Gate charge total | V_{CE} = 350 V, I_{C} = 40 A, V_{GE} = ±15 V | Qg | - | 180 | - | nC |
| Thermal Resistance - chip-to-heatsink | Thermal grease, Thickness = 2.1 Mil | R _{thJH} | - | 1.32 | - | °C/W |
| Thermal Resistance - chip-to-case | ±2% λ = 2.9 W/mK | R _{thJC} | - | 0.96 | - | °C/W |
| IGBT INVERSE DIODE (D12, D14, D21, D2 | 22) | | | | | |
| Forward voltage | I _F = 50 A, T _j = 25°C I _F = 50 A, T _j = 175°C | V _F | | 2.25 1.7 | 2.7 _ | V |
| Reverse Recovery Time | | t _{rr} | - | 28 | - | ns |
| Reverse Recovery Current | − T _i = 25°C | Q _{rr} | - | 281 | - | nc |
| Peak Reverse Recovery Current | V _{CE} = 350 V, I _C = 50 A | I _{rrm} | - | 18 | - | А |
| Peak Rate of Fall of Recovery Current | $V_{GE} = 15 \text{ V}, -9 \text{ V}, \text{ R}_{G} = 6 \Omega$ | Di/dt _{max} | - | 1.42 | _ | A/μs |
| Reverse Recovery Energy | | E _{rr} | - | 33 | - | μJ |
| Reverse Recovery Time | | t _{rr} | - | 65 | - | ns |
| Reverse Recovery Current | | Q _{rr} | - | 1094 | - | nc |
| Peak Reverse Recovery Current | $V_{CF} = 350 \text{ V}, \text{ I}_{C} = 50 \text{ A}$ | I _{rrm} | - | 33 | - | А |
| Peak Rate of Fall of Recovery Current | $V_{GE} = 15 \text{ V}, -9 \text{ V}, \text{ R}_{G} = 6 \Omega$ | Di/dt _{max} | - | 1.32 | - | A/μs |
| Reverse Recovery Energy | | E _{rr} | - | 198 | - | μJ |
| Thermal Resistance - chip-to-heatsink | Thermal grease, Thickness = 2.1 Mil | R _{thJH} | - | 1.10 | - | °C/W |
| Thermal Resistance - chip-to-case | ±2% λ = 2.9 W/mK | R _{thJC} | - | 0.79 | - | °C/W |
| DIODE (D20) | - | | - | - | | - |
| Forward voltage | $ I_F = 50 \text{ A}, T_j = 25^{\circ}\text{C} \\ I_F = 50 \text{ A}, T_j = 175^{\circ}\text{C} $ | V _F | | 2.25 1.7 | 2.7 _ | V |
| Reverse leakage current | $V_{CE} = 650 \text{ V}, V_{GE} = 0 \text{ V}$ | I _r | - | - | 300 | μΑ |
| Thermal Resistance - chip-to-heatsink | Thermal grease, Thickness = 2.1 Mil | R _{thJH} | - | 1.10 | - | °C/W |
| Thermal Resistance - chip-to-case | ±2% λ = 2.9 W/mK | R _{thJC} | - | 0.79 | _ | °C/W |
| THERMISTOR CHARACTERISTICS | • | | | | | |
| Nominal resistance | T = 25°C | R ₂₅ | - | 22 | - | kΩ |
| Nominal resistance | T = 100°C | R ₁₀₀ | - | 1486 | - | Ω |
| Deviation of R25 | | R/R | -5 | - | 5 | % |
| Power dissipation | | PD | - | 200 | - | mW |
| Power dissipation constant | | | - | 2 | - | mW/°C |
| B-value | B (25/50), tol ±3% | | - | - | 3950 | °C |
| B-value | B (25/100), tol ±3% | | - | - | 3998 | °C |
| NTC reference | İ. | 1 | - | - | В | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

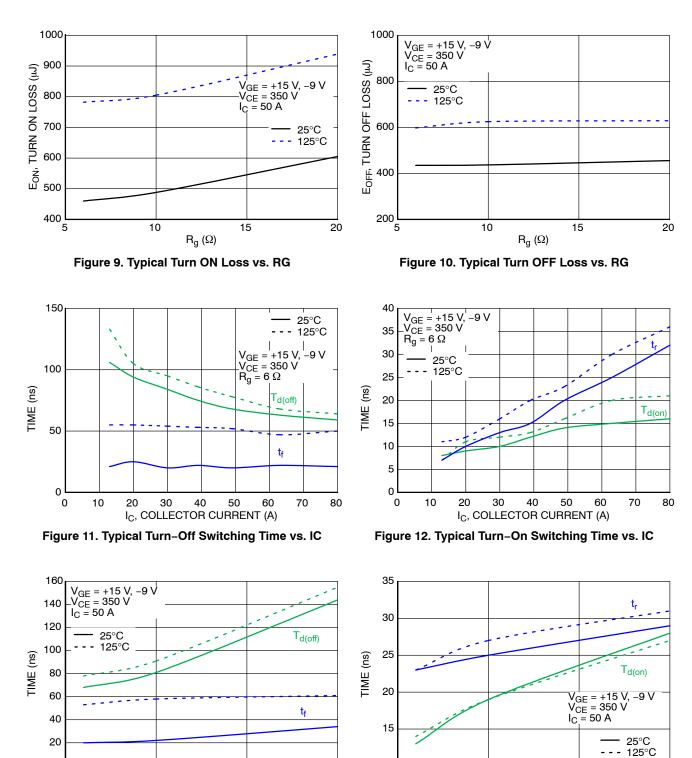
TYPICAL CHARACTERISTICS - IGBT (T11, T12, T13, T14, T21, T22)







TYPICAL CHARACTERISTICS - (T11, T12, T13, T14) IGBT COMMUTATES D21, D22 DIODE (continued)







0

Figure 14. Typical Turn-On Switching Time vs. Rg

R_a, GATE RESISTOR (Ω)

15

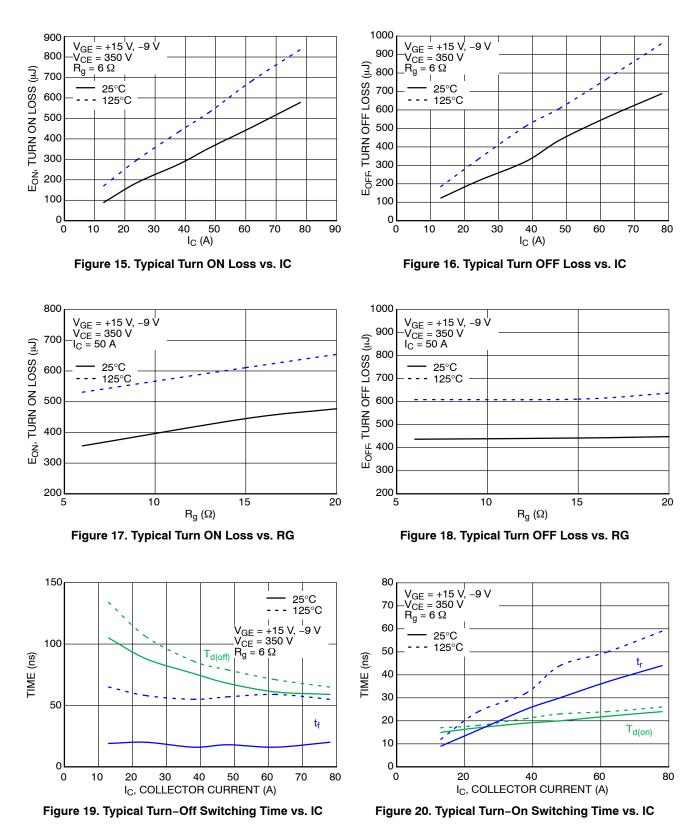
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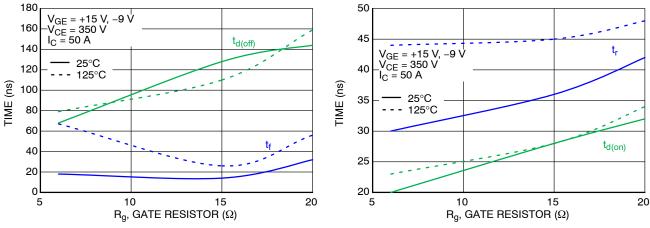
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TYPICAL CHARACTERISTICS - (T21, T22) IGBT COMMUTATES D20 DIODE



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TYPICAL CHARACTERISTICS - (T21, T22) IGBT COMMUTATES D20 DIODE (continued)



TYPICAL CHARACTERISTICS – DIODE

Figure 21. Typical Turn-Off Switching Time vs. Rg



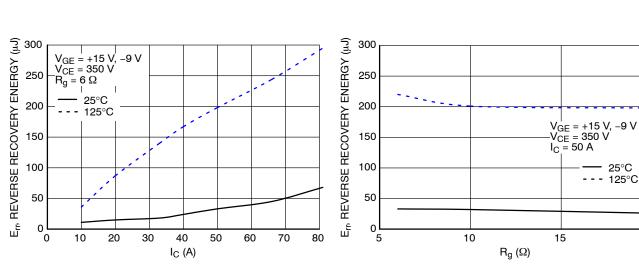
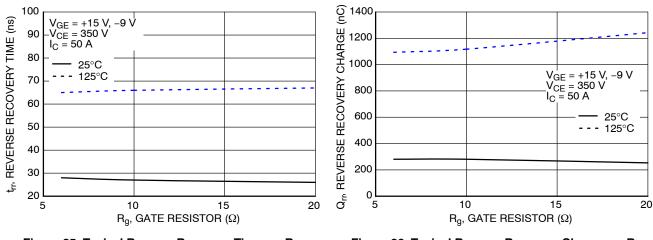
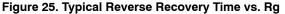


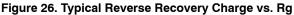
Figure 23. Typical Reverse Recovery Energy Loss vs. IC



20







TYPICAL CHARACTERISTICS - DIODE (continued)

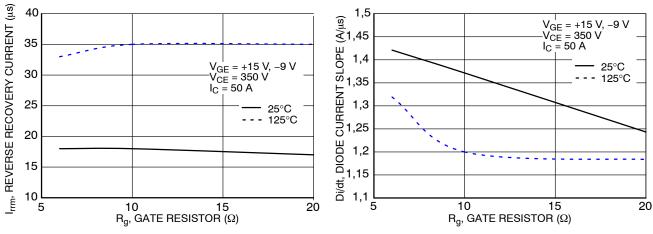
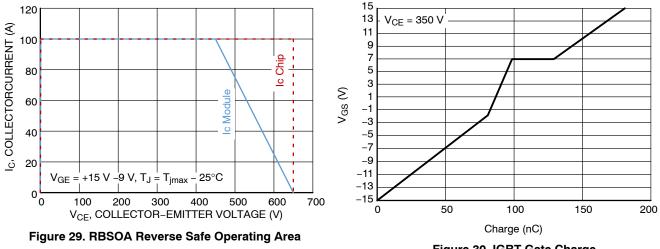


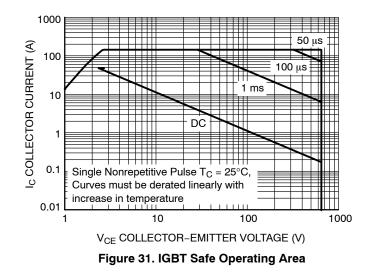
Figure 27. Typical Reverse Recovery Peak Current vs. Rg



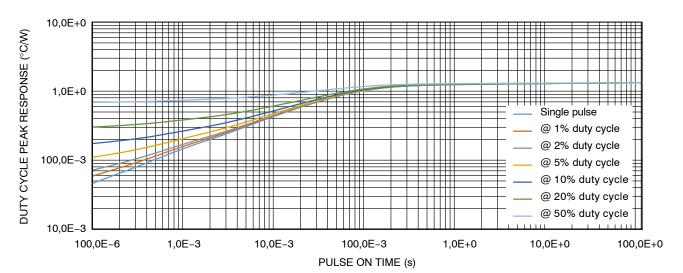








TYPICAL THERMAL CHARACTERISTICS





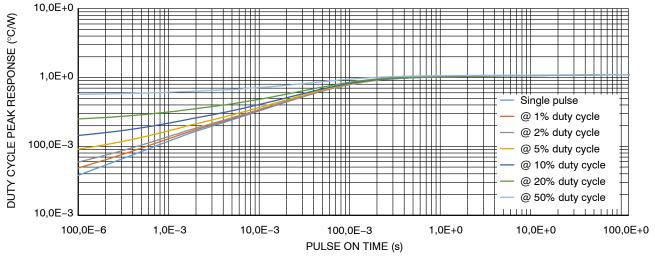
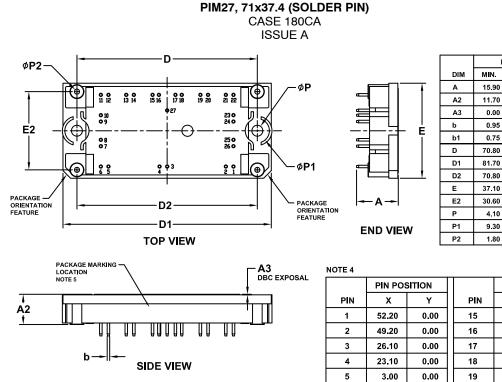


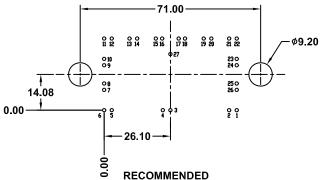
Figure 33. Transient Thermal Impedance – Diode

ORDERING INFORMATION

| Device | Package Type | Status | Shipping |
|--------------------------------|--------------------------|----------------|------------------|
| NXH50M65L4Q1SG (Solder Pin) | PIM27, 71x37.4 Q1PACK | In Development | 21 Units / BTRAY |
| NXH50M65L4Q1PTG (Pressfit Pin) | PIM27, 71x37.4 Q1PACK | In Development | 21 Units / BTRAY |

PACKAGE DIMENSIONS





| | PIN POSITION | | | PIN POS | SITION |
|-----|--------------|-------|-----|---------|--------|
| PIN | х | Y | PIN | x | Y |
| 1 | 52.20 | 0.00 | 15 | 20.35 | 28.20 |
| 2 | 49.20 | 0.00 | 16 | 22.85 | 28.20 |
| 3 | 26.10 | 0.00 | 17 | 29.35 | 28.20 |
| 4 | 23.10 | 0.00 | 18 | 31.85 | 28.20 |
| 5 | 3.00 | 0.00 | 19 | 29.20 | 28.20 |
| 6 | 0.00 | 0.00 | 20 | 42.20 | 28.20 |
| 7 | 0.00 | 8.00 | 21 | 49.20 | 28.20 |
| 8 | 0.00 | 10.50 | 22 | 52.20 | 28.20 |
| 9 | 0.00 | 17.70 | 23 | 52.20 | 20.20 |
| 10 | 0.00 | 20.20 | 24 | 52.20 | 17.70 |
| 11 | 0.00 | 28.20 | 25 | 52.20 | 10.50 |
| 12 | 3.00 | 28.20 | 26 | 52.20 | 8.00 |
| 13 | 10.00 | 28.20 | 27 | 26.10 | 22.10 |
| 14 | 13.00 | 28.20 | | | |

MILLIMETERS

NOM.

16.40

11.90

0.20

1.00

0.80

71.00

82.00

71.00

37.40

30.80

4.30

9.50

2.00

0.00

1.80

MAX.

16.90

12.10

0.60

1.05

0.85

71.20

82.30

71.20

37.70

31.00

4.50

9.70

2.20

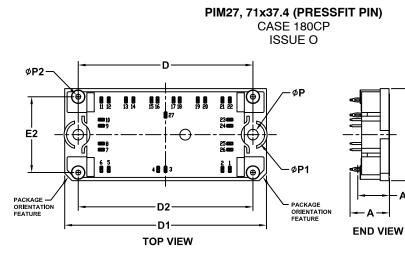
* For additional Information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

MOUNTING PATTERN

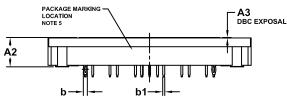
NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009
- 2. CONTROLLING DIMENSION : MILLIMETERS
- 3. DIMENSIONS b AND b1 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION A1
- 4. PIN POSITION TOLERANCE IS ± 0.4mm
- 5. PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE **OPPOSITE THE PACKAGE ORIENTATION FEATURES**

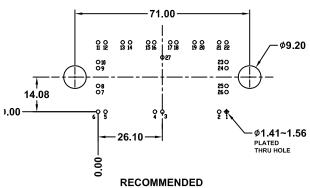
PACKAGE DIMENSIONS



| | MILLIMETERS | | | | |
|-----|-------------|---------|-------|--|--|
| DIM | MIN. | MIN NOM | | | |
| A | 15.50 | 16.00 | 16.50 | | |
| A1 | 12.38 | 12.88 | 13.38 | | |
| A2 | 11.70 | 11.90 | 12.10 | | |
| A3 | 0.00 | 0.20 | 0.60 | | |
| b | 1.61 | 1.66 | 1.71 | | |
| b1 | 0.75 | 0.80 | 0.85 | | |
| D | 70.80 | 71.00 | 71.20 | | |
| D1 | 81.70 | 82.00 | 82.30 | | |
| D2 | 70.80 | 71.00 | 71.20 | | |
| E | 37.10 | 37.40 | 37.70 | | |
| E2 | 30.60 | 30.80 | 31.00 | | |
| Р | 4.10 | 4.30 | 4.50 | | |
| P1 | 9.30 | 9.50 | 9.70 | | |
| P2 | 1.80 | 2.00 | 2.20 | | |







MOUNTING PATTERN

* For additional Information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009
- 2. CONTROLLING DIMENSION : MILLIMETERS
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- 4. PIN POSITION TOLERANCE IS ± 0.4mm
- 5. PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE **OPPOSITE THE PACKAGE ORIENTATION FEATURES**

| | | L | | | .00 | 2.00 | 2.20 |
|--------|--------------|-------|----|-----|-----|--------------|-------|
| NOTE 4 | NOTE 4 | | | | | | |
| | PIN POSITION | | | | Р | PIN POSITION | |
| PIN | х | Y | | PIN | | х | Y |
| 1 | 52.20 | 0.00 | | 15 | 2 | 0.35 | 28.20 |
| 2 | 49.20 | 0.00 | ТГ | 16 | 2 | 2.85 | 28.20 |
| 3 | 26.10 | 0.00 | | 17 | 2 | 9.35 | 28.20 |
| 4 | 23.10 | 0.00 | | 18 | 3 | 1.85 | 28.20 |
| 5 | 3.00 | 0.00 | | 19 | 2 | 9.20 | 28.20 |
| 6 | 0.00 | 0.00 | | 20 | 4 | 2.20 | 28.20 |
| 7 | 0.00 | 8.00 | | 21 | 4 | 9.20 | 28.20 |
| 8 | 0.00 | 10.50 | | 22 | 5 | 2.20 | 28.20 |
| 9 | 0.00 | 17.70 | | 23 | 5 | 2.20 | 20.20 |
| 10 | 0.00 | 20.20 | | 24 | 5 | 2.20 | 17.70 |
| 11 | 0.00 | 28.20 | | 25 | 5 | 2.20 | 10.50 |
| 12 | 3.00 | 28.20 | | 26 | 5 | 2.20 | 8.00 |
| 13 | 10.00 | 28.20 | | 27 | 2 | 6.10 | 22.10 |
| 14 | 13.00 | 28.20 | | | | | |

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 FD400R33KF2C-K

 FD401R17KF6C_B2
 FD-DF80R12W1H3_B52
 FF200R06YE3
 FF300R12KE4_E
 FF450R12ME4P
 FF600R12IP4V
 FP20R06W1E3

 FP50R12KT3
 FP75R07N2E4_B11
 FS10R12YE3
 FS150R07PE4
 FS150R12PT4
 FS200R12KT4R
 FS50R07N2E4_B11
 FZ1000R33HE3

 FZ1800R17KF4
 DD250S65K3
 DF1000R17IE4
 DF1000R17IE4D_B2
 DF1400R12IP4D
 DF200R12PT4_B6
 DF400R07PE4R_B6

 BSM75GB120DN2_E3223c-Se
 F31300R12ME4_B22
 F3175R07W2E3_B11
 F4-50R12KS4_B11
 F475R07W1H3B11ABOMA1

 FD1400R12IP4D
 FD200R12PT4_B6
 FD800R33KF2C-K
 FF1200R17KP4_B2
 FF150R12ME3G
 FF300R17KE3_S4
 FF300R17ME4_B11

 FF401R17KF6C_B2
 FF650R17IE4D_B2
 FF900R12IP4D
 FF900R12IP4DV
 STGIF7CH60TS-L
 FP50R07N2E4_B11
 FS100R07PE4

 FS150R07N3E4_B11
 FS150R17N3E4
 FS150R07N3E4
 STGIF7CH60TS-L
 FP50R07N2E4_B11
 FS100R07PE4